



PATENT Customer No. 22,852 Attorney Docket No. 02887.0261

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	
Tomohiro SAITO) Group Art Unit: 2823
Serial No.: 10/730,903) Examiner: William M. Brewster
Filed: December 10, 2003))) Confirmation No.: 5163
For: SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THE SAME)))
Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450	,
Sir:	

RESPONSE TO RESTRICTION REQUIREMENT

In a restriction requirement mailed June 22, 2005, the period for response to which extends through July 22, 2005, the Examiner required restriction under 35 U.S.C. § 121 between Group I, claims 1-12, characterized by the Examiner as being drawn to a method of selective etching of silicon material; and Group II, claims 13 and 14, characterized by the Examiner as being drawn to a field effect device with insulated electrode; Applicant provisionally elects to prosecute Group I, claims 1-12, without traverse.

Please grant any extensions of time required to enter this response and charge any additional required fees to our deposit account 06-0916.

Respectfully submitted,

FINNEGAN, HENDERSON, FARABOW,

GARRETT & DUNNER, L.L.P.

Dated: July 22, 2005

Richard V. Burgujian

Reg. No. 31,744